

STGW20NB60H

N-CHANNEL 20A - 600V TO-247 PowerMESHTM IGBT

TYPE	V _{CES}	V _{CE(sat)}	Ι _C					
STGW20NB60H	600 V	< 2.8 V	20 A					

- HIGH INPUT IMPEDANCE (VOLTAGE DRIVEN)
- LOW ON-VOLTAGE DROP (V_{CESAT})
- LOW GATE CHARGE
- HIGH CURRENT CAPABILITY
- VERY HIGH FREQUENCY OPERATION
- OFF LOSSES INCLUDE TAIL CURRENT

DESCRIPTION

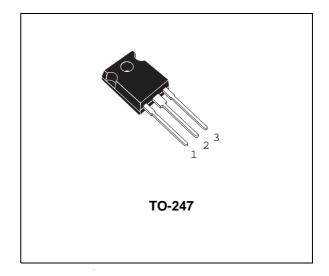
Using the latest high voltage technology based on a patented strip layout, STMicroelectronics has designed an advanced family of IGBTs, the PowerMESHTM IGBTs, with outstanding perfomances. The suffix "H" identifies a family optimized to achieve very low switching times for high frequency applications (<120kHz).

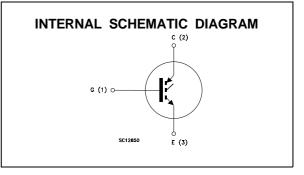
APPLICATIONS

- HIGH FREQUENCY MOTOR CONTROLS
- WELDING EQUIPMENTS

ABSOLUTE MAXIMUM RATINGS

 SMPS AND PFC IN BOTH HARD SWITCH AND RESONANT TOPOLOGIES





Symbol	Parameter	Value	Unit
V _{CES}	Collector-Emitter Voltage (V _{GS} = 0)	600	V
V _{ECR}	Emitter-Collector Voltage	20	V
V _{GE}	Gate-Emitter Voltage	± 20	V
Ιc	Collector Current (continuous) at $T_c = 25$ °C	40	А
Ιc	Collector Current (continuous) at T _c = 100 °C	20	А
I _{CM} (●)	Collector Current (pulsed)	160	Α
P _{tot}	Total Dissipation at $T_c = 25 \ ^{\circ}C$	150	W
	Derating Factor	1.2	W/°C
T _{stg}	Storage Temperature	-65 to 150	°C
Tj	Max. Operating Junction Temperature	150	°C

(•) Pulse width limited by safe operating area

THERMAL DATA

Ī	R _{thj-case}	Thermal	Resistance	Junction-case	Max	0.83	°C/W
	R _{thj-amb}	Thermal	Resistance	Junction-ambient	Max	30	oC/W
	R _{thc-h}	Thermal	Resistance	Case-heatsink	Тур	0.1	°C/W

ELECTRICAL CHARACTERISTICS (T_j = 25 $^{\circ}$ C unless otherwise specified) OFF

Symbol	Parameter	Test Conditions	Min.	Тур.	Max.	Unit
V _{BR(CES)}	Collector-Emitter Breakdown Voltage	$I_{C} = 250 \ \mu A$ $V_{GE} = 0$	600			V
I _{CES}	Collector cut-off (V _{GE} = 0)				10 100	μΑ μΑ
I _{GES}	Gate-Emitter Leakage Current (V _{CE} = 0)	$V_{GE} = \pm 20 \text{ V} \qquad V_{CE} = 0$			± 100	nA

ON (*)

Symbol	Parameter	Test Conditions	Min.	Тур.	Max.	Unit
$V_{\text{GE(th)}}$	Gate Threshold Voltage	$V_{CE} = V_{GE}$ I _C = 250 µA	3		5	V
V _{CE(SAT)}		$ \begin{array}{lll} V_{GE} = 15 \ V & I_C = 20 \ A \\ V_{GE} = 15 \ V & I_C = 20 \ A & T_j = 125 \ ^oC \end{array} $		2.3 1.9	2.8	V V

DYNAMIC

Symbol	Parameter	Test Conditions	Min.	Тур.	Max.	Unit
g fs	Forward Transconductance	V _{CE} =25 V I _C = 20 A	7.0	10		S
Cies C _{oes} C _{res}	Input Capacitance Output Capacitance Reverse Transfer Capacitance	$V_{CE} = 25 V$ f = 1 MHz $V_{GE} = 0$	1200 140 28	1700 200 40	2200 260 52	pF pF pF
Q _G Q _{GE} Q _{GC}	Total Gate Charge Gate-Emitter Charge Gate-Collector Charge	$V_{CE} = 480 \text{ V}$ I _C = 20 A V _{GE} = 15 V		110 13 51	145	nC nC nC
I _{CL}	Latching Current	$V_{clamp} = 480 V$ R _G =10 Ω T _j = 150 °C	80			A

SWITCHING ON

Symbol	Parameter	Test Condit	tions	Min.	Тур.	Max.	Unit
t _{d(on)} t _r	Delay Time Rise Time	V _{CC} = 480 V V _{GE} = 15 V	$I_{C} = 20 \text{ A}$ $R_{G} = 10\Omega$		20 70		ns ns
(di/dt) _{on}	Turn-on Current Slope	$V_{CC} = 480 \text{ V}$ $R_{G} = 10 \Omega$	I _C = 20 A V _{GE} = 15 V		350		A/µs
Eon	Turn-on Switching Losses	T _j = 125 °C			300		μJ

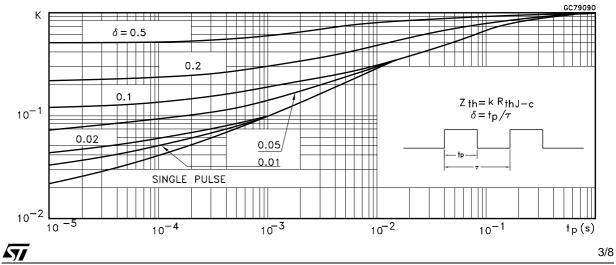
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ELECTRICAL CHARACTERISTICS (continued) SWITCHING OFF

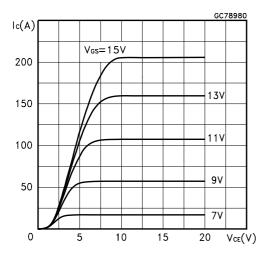
Symbol	Parameter	Test Co	nditions	Min.	Тур.	Max.	Unit
t _c t _r (v _{off})	Cross-Over Time Off Voltage Rise Time	V _{CC} = 480 V R _{GE} = 10 Ω	I _C = 20 A V _{GE} = 15 V		115 32		ns ns
$t_{d(off)}$ t_{f}	Delay Time Fall Time				170 75		ns
E _{off} (**) E _{ts}	Turn-off Switching Loss Total Switching Loss				0.4 0.65		mJ mJ
$\begin{array}{c} t_c \\ t_r(v_{off}) \\ t_d(_{off}) \\ t_f \\ E_{off}(^{**}) \\ E_{ts} \end{array}$	Cross-Over Time Off Voltage Rise Time Delay Time Fall Time Turn-off Switching Loss Total Switching Loss	VCC = 480 V $R_{GE} = 10 \Omega$ $T_j = 125 \ ^{\circ}C$	I _C = 20 A V _{GE} = 15 V		190 55 210 140 0.7 1.0		ns ns ns mJ mJ

(•) Pulse width limited by max. junction temperature (*) Pulsed: Pulse duration = $300 \ \mu$ s, duty cycle 1.5 % (**)Losses Include Also The Tail (Jedec Standardization)

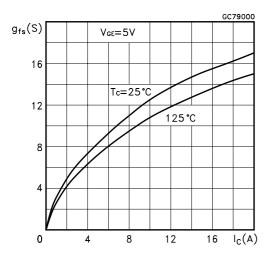
Thermal Impedance



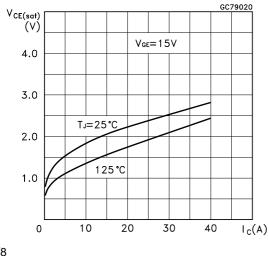
Output Characteristics



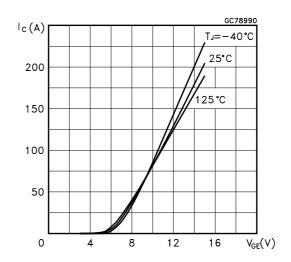
Transconductance



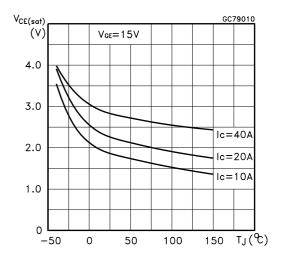
Collector-Emitter On Voltage vs Collector Current

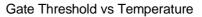


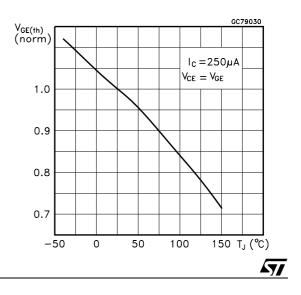
Transfer Characteristics



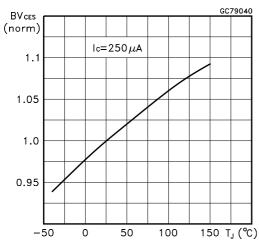
Collector-Emitter On Voltage vs Temperature





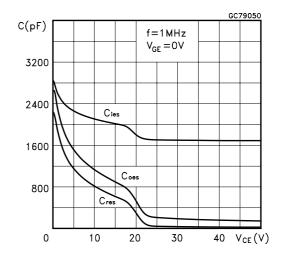


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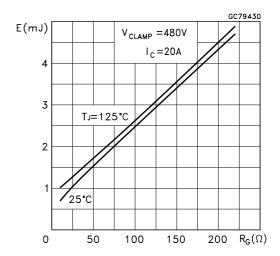


Normalized Breakdown Voltage vs Temperature

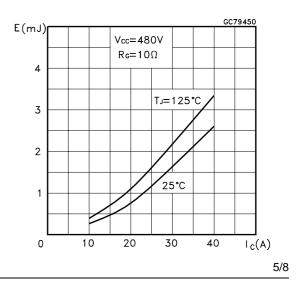
Capacitance Variations



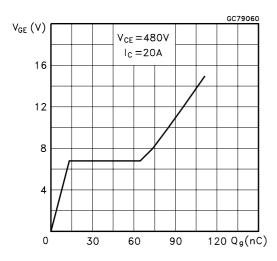
Total Switching Losses vs Gate Resistance



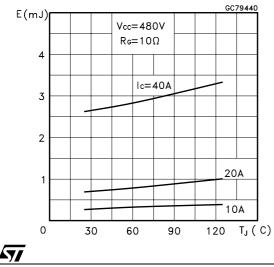
Total Switching Losses vs Collector Current



Gate Charge vs Gate-Emitter Voltage



Total Switching Losses vs Temperature



Switching Off Safe Operating Area

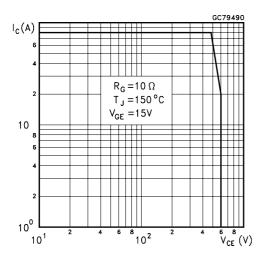
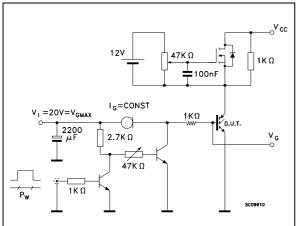
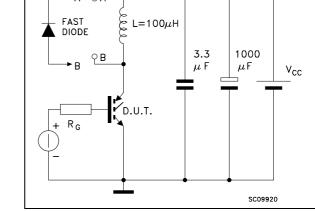


Fig. 1: Gate Charge test Circuit

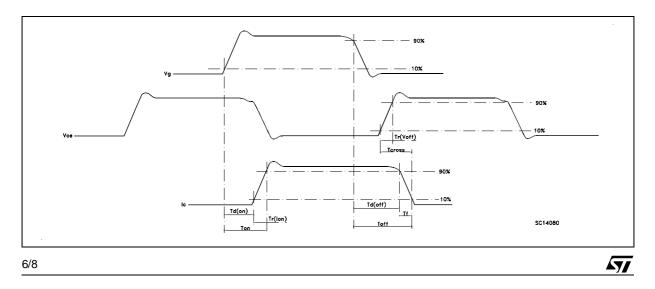


►A 0A L=100µH

Fig. 2: Test Circuit For Inductive Load Switching

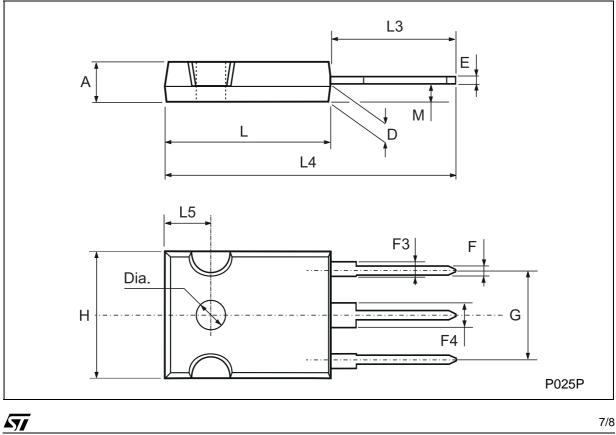






DIM.		mm			inch	
Diwi.	MIN.	TYP.	MAX.	MIN.	TYP.	MAX.
А	4.7		5.3	0.185		0.209
D	2.2		2.6	0.087		0.102
E	0.4		0.8	0.016		0.031
F	1		1.4	0.039		0.055
F3	2		2.4	0.079		0.094
F4	3		3.4	0.118		0.134
G		10.9			0.429	
Н	15.3		15.9	0.602		0.626
L	19.7		20.3	0.776		0.779
L3	14.2		14.8	0.559		0.582
L4		34.6			1.362	
L5		5.5			0.217	
М	2		3	0.079		0.118





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